# MT4953A1

# P-Channel Enhancement Mode Field Effect Transistor

### **Product Summary**

- VDS= -20V
- ID= -4.5A
- RDS(ON) =  $95m\Omega$ @VGS= -4.5V/-3.6A

### **Features**

- Advanced Trench Process Technology.
- · High Density Cell Design for Ultra Low
- On-Resistance.
- · Lead free product is acquired.
- · RoHS Compliant.

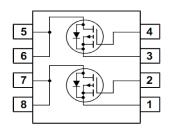
### **Applications:**

- · Load Switch.
- PWM Applications.

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### **Simplified Schematic**



MARKING DIAGRAM & PIN ASSIGNMENT



### **Absolute Maximum Ratings** (T<sub>A</sub> = 25℃ unless otherwise noted)

Symbol	Parameter	Steady State	Units
V <sub>DS</sub>	Drain-Source Voltage	-20	V
V <sub>GS</sub>	Gate-Source Voltage	±12	V
I <sub>D</sub>	Continuous Drain Current <sup>1</sup>	-4.5	Α
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	-25	A
Is	Continuous Source Current (Diode Conduction) 1	-2	A
P <sub>D</sub>	Maximum Power Dissipation <sup>1</sup>	1.8	W
T <sub>J</sub> , T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55~150	$^{\circ}$

### Notes:

- 1. Surface Mounted on 1" x 1" FR4 Board, t≦ 10 Sec.
- 2. Pulse width limited by maximum junction temperature.

### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT4953A1	MT4953A1	SO-8	1	-	2500

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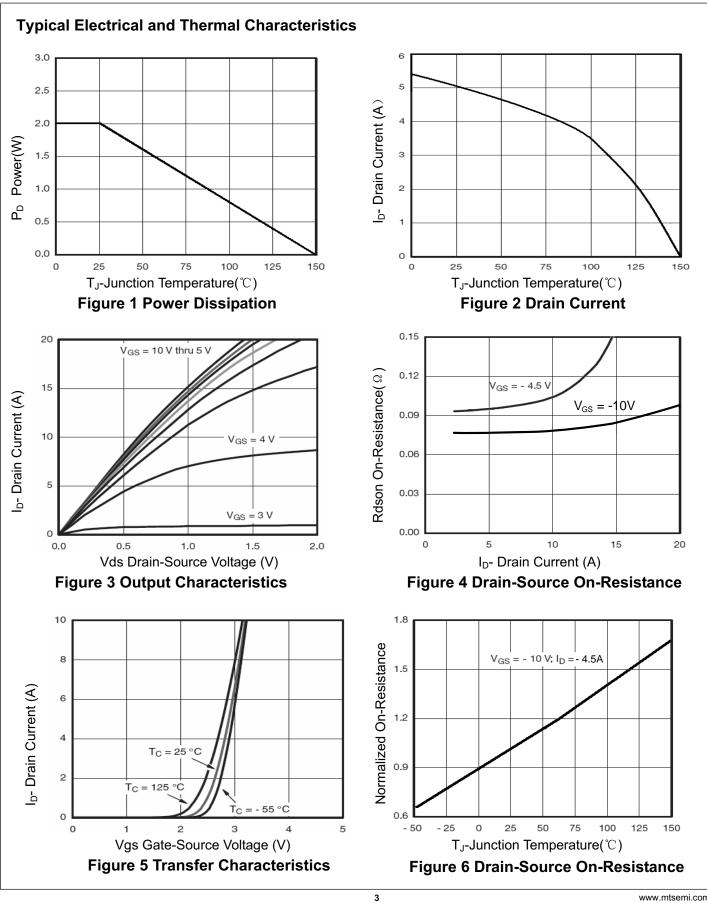
### **Thermal Characteristic**

Thermal Resistance ,Junction-to-Ambient <sup>(Note 2)</sup>	R <sub>0JA</sub>	62.5	°C/W	1
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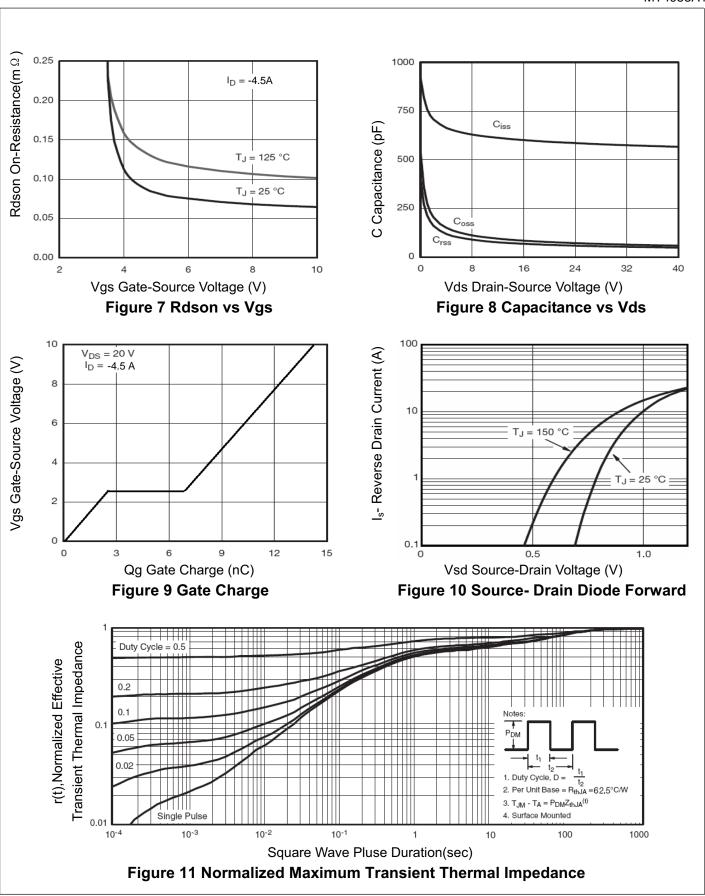
### Electrical Characteristics (T<sub>A</sub>=25 ℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-20	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-20V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±12V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)			•	•		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$ , $I_D=-250\mu A$	-	-0.7	-1.0	V
Drain-Source On-State Resistance	D	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.5A	-	80	85	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3.6A	-	95	105	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =-15V,I <sub>D</sub> =-3.1A	10	-	-	S
Dynamic Characteristics (Note4)	<u> </u>		•			
Input Capacitance	C <sub>lss</sub>	V - 00VVV -0V	-	600	-	PF
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =-20V, $V_{GS}$ =0V, F=1.0MHz	-	90	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F-1.UIVITZ	-	70	-	PF
Switching Characteristics (Note 4)	<u> </u>		•			
Turn-on Delay Time	t <sub>d(on)</sub>		-	9	-	nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =-20 $V$ , $R_L$ =2 $\Omega$	-	8	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-10 $V$ , $R_{GEN}$ =3 $\Omega$	-	28	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	10	-	nS
Total Gate Charge	Qg	\/ - 20\/ L - 4.5A	-	14	-	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ =-20V, $I_{D}$ =-4.5A,	-	2.9	-	nC
Gate-Drain Charge	$Q_{gd}$	V <sub>GS</sub> =-10V	-	3.8	-	nC
Drain-Source Diode Characteristics			•		-	•
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-1A	-	-0.8	-1.2	V
Diode Forward Current (Note 2)	Is		-	-	-4.5	Α

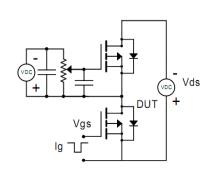
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.4. Guaranteed by design, not subject to production

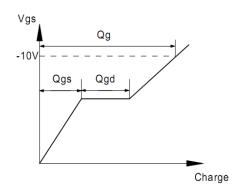


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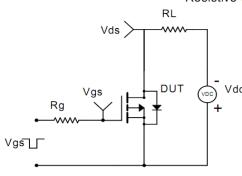
### Gate Charge Test Circuit & Waveform

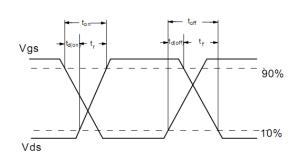




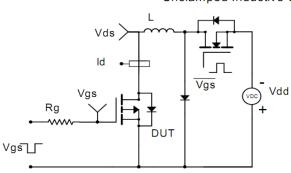
Resistive Switching Test Circuit & Waveforms

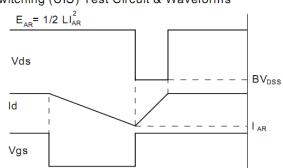
### Resistive Switching Test Circuit & Waveforms



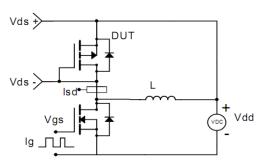


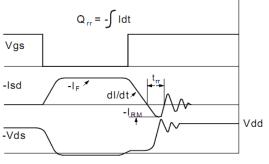
### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





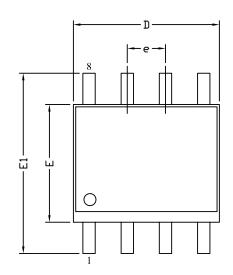
### Diode Recovery Test Circuit & Waveforms

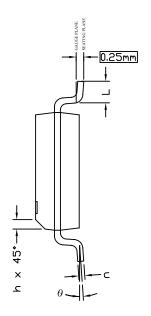


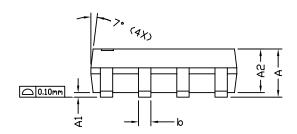


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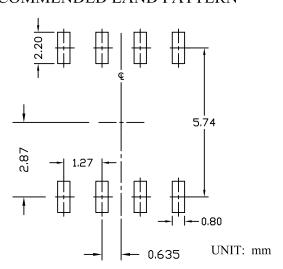
### SO8 PACKAGE OUTLINE







### RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIC	NS IN MILL	IMETERS	DIME	NSIONS IN IN	CHES
S I MBOLS	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.35	1.65	1.75	0.053	0.065	0.069
A1	0.10		0.25	0.004		0.010
A2	1.25	1.50	1.65	0.049	0.059	0.065
b	0.31		0.51	0.012		0.020
c	0.17		0.25	0.007		0.010
D	4.80	4.90	5.00	0.189	0.193	0.197
Е	3.80	3.90	4.00	0.150	0.154	0.157
e	1	.27 BSC		0	0.050 BSC	7
E1	5.80	6.00	6.20	0.228	0.236	0.244
h	0.25		0.50	0.010		0.020
L	0.40		1.27	0.016		0.050
θ	00		80	00		80

### NOTE

- 1. ALL DIMENSIONS ARE IN MILLMETERS.
- 2. DIMENSIONS ARE INCLUSIVE OF PLATING.
- 3. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 4. DIMENSION L IS MEASURED IN GAUGE PLANE.
- 5. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

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## **Part Marking Information**

# SO-8 (PMG Code)

### **SO-8 Devices**



MT4953A = Example Base Part Number

• = Pin 1 Indicator

△ = ESD Symbol 🖾

9 = Year Code

A = Month Code

3 = Week Code

H = Assembly Factory Code

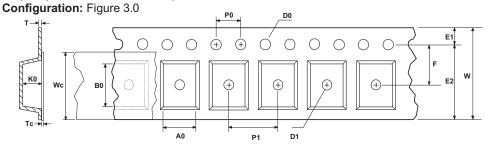
### NOTE:

1. For analog switches base part includes DG prefix. Package suffix may or may not be present, depending on room available.

The current marking strategy is reflected. Contact your local sales representative for historical marking strategies for these packages.

### SO-8 Tape and Reel Data, continued

### SO(8lds) Embossed Carrier Tape



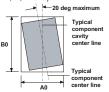


	Dimensions are in millimeter													
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	Т	Wc	Тс
SOIC(8lds) (12mm)	6.50 +/-0.10	5.30 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.1 +/-0.10	0.450 +/- 0.150	9.2 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



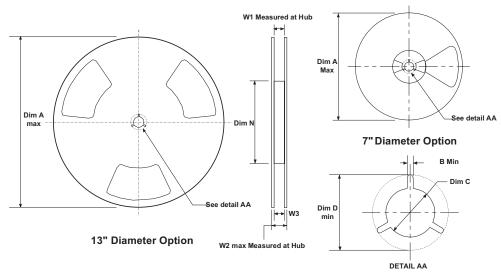
Sketch B (Top View)
Component Rotation



Sketch C (Top View)

Component lateral movement

### SOIC(8lds) Reel Configuration: Figure 4.0



	Dimensions are in inches and millimeters										
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)		
12mm	7" Dia	7.00 177.8	0.059 1.5	512+0.020/-0.008 13+0.5/-0.2	0.795 20.2	2.165 55	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4		
12mm	13" Dia	13.00 330	0.059 1.5	512+0.020/-0.008 13+0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4		

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